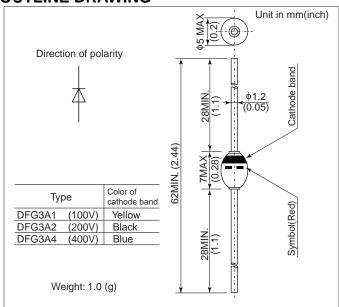
DFG3A

FEATURES

- For high speed switching.
- Diffused-junction. Glass passivated and encapsulated.

OUTLINE DRAWING



ABSOLUTE MAXIMUM RATINGS

7.B002012 III/ (7.III/00											
Items	Туре		DFG3A1	DFG3A2	DFG3A4						
Repetitive Peak Reverse Voltage	V_{RRM}	V	100	200	400						
Average Forward Current	I _{F(AV)}	А	3.0 (Single-phase half sine wave 180° conduction TL = 60°C, Lead length = 10mm								
Surge(Non-Repetitive) Forward Current	I _{FSM}	Α	70(Without PIV, 10ms conduction, Tj = 150°C start)								
I ² t Limit Value	l ² t	A ² s	19.6(Time = 2 ~ 10ms, I = RMS value)								
Operating Junction Temperature	Tj	°C	-65 ~ +150								
Storage Temperature	T _{stg}	°C	-65 ~ +150								

Notes (1) Lead mounting: Lead temperature 300°C max. to 3.2mm from body for 5sec. max..

(2) Mechanical strength: Bending 90°×2 cycles or 180°×1 cycle, Tensile 3kg, Twist 90°×1 cycle.

CHARACTERISTICS(T_L=25°C)

Items	Symbols	Units	Min.	Тур.	Max.	Test Conditions
Peak Reverse Current	I _{RRM}	μΑ	_	2.0	10	Rated V _{RRM}
Peak Forward Voltage	V_{FM}	V	-	_	1.3	I _{FM} =3.0Ap, Single-phase half sine wave 1 cycle
Reverse Recovery Time	trr	μs	1	_	0.1	I _F =0.5A, I _{rp} =1.0A, 25% Recovery
Steady State Thermal Impedance	R _{th(j-a)}	°C/W	_	_	50 20	Lead length = 10 mm

DFG3A

Forward characteristics

Single-phase half sine wave Conduction : 10ms 1 Cycle

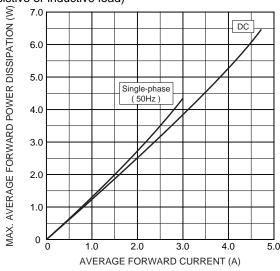
TL=150'C

TL=25'C

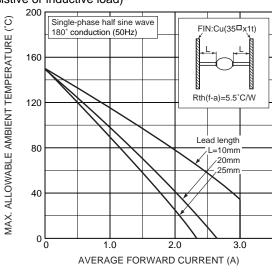
TL=25'C

PEAK FORWARD VOLTAGE DROP (V)

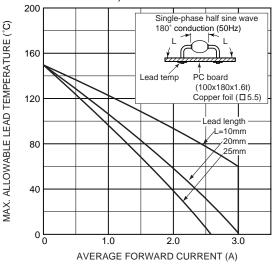
Max. average forward power dissipation (Resistive or inductive load)



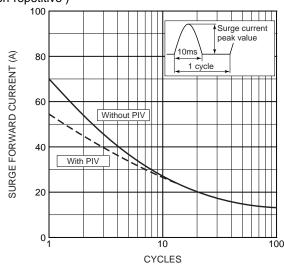
Max. allowable ambient temperature (Resistive or inductive load)



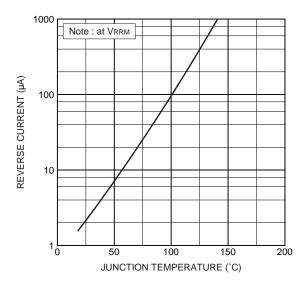
Max. allowable lead temperature (Resistive or inductive load)



Surge forward current characteristics (Non-repetitive)

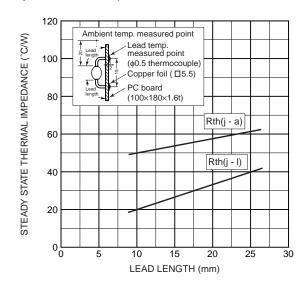


Typ. Reverse current vs. junction temperature

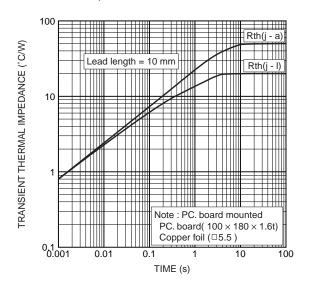


DFG3A

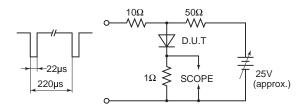
Steady state thermal impedance

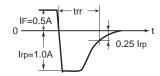


Transient thermal impedance



Reverse recovery time (trr) test circuit





Precautions for Safe Use and Notices

If semiconductor devices are handled inappropriate manner, failures may result. For this reason, be sure to read "Precaution for Use" before use.



This mark indicates an item about which caution is required.



CAUTION

This mark indicates a potentially hazardous situation which, if not avoided, may result in minor or moderate injury and damage to property.

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CAUTION

- (1) Regardless of changes in external conditions during use "absolute maximum ratings" should never be exceed in designing electronic circuits that employ semiconductors. In the case of pulse use, furthermore, "safe operating area(SOA)" precautions should be observed.
- (2) Semiconductor devices may experience failures due to accident or unexpected surge voltages. Accordingly, adopt safe design features, such as redundancy or prevention of erroneous action, to avoid extensive damage in the event of a failure.
- (3) In cases where extremely high reliability is required (such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of user's fail-safe precautions or other arrangement. Or consult Hitachi's sales department staff.

(If a semiconductor device fails, there may be cases in which the semiconductor device, wiring or wiring pattern will emit smoke or cause a fire or in which the semiconductor device will burst)

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